CTB



TEST REPORT

Pr	roduct Name:	Bluetooth Speaker	
	CC ID:	2BL3L-AD1005	
	rademark:	N/A	
	odel Number:	AD1005	
Pr	repared For:	CICA HOMORE INC	
	ddress:	11190 White Birch Dr Suite 100, Rancho	Cucamonga, CA 91730
М	anufacturer:	NINGBO YINZHOU KARMAS FAR IMP.&	
A	ddress:	Room B603, No.122, Lane155, Jingu Nord Zhejiang, China	th Road, Yinzhou District, Ningbo City,
Pr	repared By:	Shenzhen CTB Testing Technology Co., L	_td.
A	ddress:	1&2/F., Building A, No.26, Xinhe Road, Xi Shenzhen, Guangdong, China	nqiao, Xinqiao Street, Bao'an District,
Sa	ample Received Date:	Sep. 23, 2024	
Sa	ample tested Date:	Sep. 23, 2024 to Nov. 04, 2024	
Is	sue Date:	Nov. 04, 2024	
R	eport No.:	CTB241009022RFX	
Te	est Standards	FCC CFR Title 47 Part 15 Subpart C Sect ANSI C63.10:2013	ion 15.247
Te	est Results	PASS	
R	emark:	This is Bluetooth radio test report.	
	Compiled by:	Reviewed by:	Approved by:

Zhou kuż

Arroin 220



<u>Zhou Kui</u>

Arron Liu

Bin Mei / Director

Note: If there is any objection to the inspection results in this report, please submit a written report to the company within 15 days from the date of receiving the report. The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen CTB Testing Technology Co., Ltd. this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client. "*" indicates the testing items were fulfilled by subcontracted lab. "#" indicates the items are not in CNAS accreditation scope.



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(Note: N/A means not applicable)



1. VERSION

Report No.	Issue Date	Description	Approved
CTB241009022RFX	Nov. 04, 2024	Original	Valid



2. TEST SUMMARY

The Product has been tested according to the following specifications:

Test Item	Test Requirement	Test method	Result	
AC Power Line Conducted Emission	47 CFR Part 15 Subpart C Section 15.207	ANSI C63.10-2013	PASS	
Radiated Spurious emissions	47 CFR Part 15 Subpart C Section 15.205/15.209	ANSI C63.10-2013	PASS	
Band edge and RF Conducted Spurious Emissions	47 CFR Part 15 Subpart C Section 15.247(d)/15.205(a)	ANSI C63.10-2013	PASS	
Conducted Peak Output Power	47 CFR Part 15 Subpart C Section 15.247 (b)(1)	ANSI C63.10-2013	PASS	
20dB Occupied Bandwidth	47 CFR Part 15 Subpart C Section 15.247 (a)(1)	ANSI C63.10-2013	PASS	
Carrier Frequencies Separation	47 CFR Part 15 Subpart C Section 15.247 (a)(1)	ANSI C63.10-2013	PASS	
Hopping Channel Number	47 CFR Part 15 Subpart C Section 15.247 (b)	ANSI C63.10-2013	PASS	
Dwell Time	47 CFR Part 15 Subpart C Section 15.247 (a)(1)	ANSI C63.10-2013	PASS	
Pseudorandom Frequency Hopping Sequence	47 CFR Part 15 Subpart C Section 15.247(a)&TCB Exclusion List (7 July 2002)	ANSI C63.10-2013	PASS	
Antenna Requirement	47 CFR Part 15 Subpart C Section 15.203/15.247 (b)		PASS	
RF Exposure Evaluation	47 CFR Part 15 Subpart C Section 15.247 (i)/1.1310/2.1093	KDB447498D01v06	PASS	

Remark:

Test according to ANSI C63.10-2013.



3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Item	Uncertainty
Occupancy bandwidth	54.3kHz
Conducted output power Above 1G	0.9dB
Conducted output power below 1G	0.9dB
Power Spectral Density , Conduction	0.9dB
Conduction spurious emissions	2.0dB
Out of band emission	2.0dB
3m camber Radiated spurious emission(9KHz-30MHz)	4.8dB
3m camber Radiated spurious emission(30MHz-1GHz)	4.6dB
3m chamber Radiated spurious emission(1GHz-18GHz)	5.1dB
3m chamber Radiated spurious emission(18GHz-40GHz)	3.4dB
humidity uncertainty	5.5%
Temperature uncertainty	0.63°C
frequency	1×10-7
Conducted Emission (150KHz-30MHz)	3.2 dB
Radiated Emission(30MHz ~ 1000MHz)	4.8 dB
Radiated Emission(1GHz ~6GHz)	4.9 dB



4. PRODUCT INFORMATION AND TEST SETUP

4.1 Product Information

Model(s):	AD1005
Model Description:	N/A
Bluetooth Version:	Bluetooth 5.3
Hardware Version:	V1.0
Software Version:	V1.0
Operation Frequency:	Bluetooth: 2402-2480MHz
Max. RF output power:	Bluetooth: 2.807dBm
Type of Modulation:	Bluetooth: GFSK, π/4 DQPSK, 8DPSK
Antenna installation:	Bluetooth: PCB antenna
Antenna Gain:	Bluetooth: -0.76dBi
Ratings:	DC 5V charging from adapter
Tatings.	DC 3.7V by battery

4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.	Note
1	Adapter	JIYIN	JY-05100C		AE

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



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4.4 Channel List

СН	Frequency (MHz)	СН	Frequency (MHz)	СН	Frequency (MHz)	СН	Frequency (MHz)
0	2402	1	2403	2	2404	3	2405
4	2406	5	2407	6	2408	7	2409
8	2410	9	2411	10	2412	11	2413
12	2414	13	2415	14	2416	15	2417
16	2418	17	2419	18	2420	19	2421
20	2422	21	2423	22	2424	23	2425
24	2426	25	2427	26	2428	27	2429
28	2430	29	2431	30	2432	31	2433
32	2434	33	2435	34	2436	35	2437
36	2438	37	2439	38	2440	39	2441
40	2442	41	2443	42	2444	43	2445
44	2446	45	2447	46	2448	47	2449
48	2450	49	2451	50	2452	51	2453
52	2454	53	2455	54	2456	55	2457
56	2458	57	2459	58	2460	59	2461
60	2462	61	2463	62	2464	63	2465
64	2466	65	2467	66	2468	67	2469
68	2470	69	2471	70	2472	71	2473
72	2474	73	2475	74	2476	75	2477
76	2478	77	2479	78	2480	79	

4.5 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting (GFSK, π/4 DQPSK, 8DPSK)	2402MHz	2441MHz	2480MHz
Receiving (GFSK, π/4 DQPSK, 8DPSK)	2402MHz	2441MHz	2480MHz

4.6 Test Environment

Humidity(%):	54
Atmospheric Pressure(kPa):	101
Normal Voltage(DC):	3.7V
Normal Temperature(°C)	23
Low Temperature(°C)	
High Temperature(°C)	



5. TEST FACILITY AND TEST INSTRUMENT USED

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at 1&2F., Building A, No. 26, Xinhe Road, Xinqiao, Xinqiao Street, Bao'an District, Shenzhen, Guangdong, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

No.	Equipment	Manufacturer	Type No.	Serial No.	Firmware Version	Calibrated until
1	Spectrum Analyzer	Agilent	N9020A	MY52090073	A.14.16	2025/6/28
2	Power Sensor	Agilent	U2021XA	MY56120032		2025/6/28
3	Power Sensor	Agilent	U2021XA	MY56120034		2025/6/28
4	Communication test set	R&S	CMW500	108058	V3.5.80	2025/6/28
5	Spectrum Analyzer	KEYSIGHT	N9020A	MY51289897	A.14.16	2025/6/28
6	Signal Generator	Agilent	N5181A	MY50140365	A.01.60	2025/6/28
7	Vector signal generator	Agilent	N5182A	MY47420195	A.01.87	2025/6/28
8	Communication test set	Agilent	E5515C	MY50102567	B.19.07 (E1962B)	2025/6/28
9	2.4 GHz Filter	Shenxiang	MSF2400-24 83.5MS-1154	20181015001		2025/6/30
10	5 GHz Filter	Shenxiang	MSF5150-58 50MS-1155	20181015001		2025/6/30
11	Filter	Xingbo	XBLBQ-DZA 120	190821-1-1	0,0	2025/6/30
12	BT&WI-FI Automatic test software	Micowave	MTS8310	Ver. 2.0.0.0	010	5105
13	Rohde & Schwarz SFU Broadcast Test System	R&S	SFU	101017	2 of P of	2025/6/28
14	Temperature humidity chamber	Hongjing	TH-80CH	DG-15174	A SP S	2025/6/28
15	234G Automatic test software	Micowave	MTS8200	Ver. 2.0.0.0		
16	966 chamber	C.R.T.	966	0/ 0	010	2027/6/21
17	Receiver	R&S	ESPI	100362	RF_ATTEN_7 (104489/003)	2025/6/28
18	Amplifier	HP	8447E	2945A02747		2025/6/28
19	Amplifier	Agilent	8449B	3008A01838		2025/6/28
20	TRILOG Broadband Antenna	Schwarzbeck	VULB 9168	00869		2025/6/28
21	Double Ridged Broadband Horn Antenna	Schwarzbeck	BBHA9120D	01911		2025/6/28

5.2 Test Instrument Used

Report



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22	EMI test software	Fala	EZ-EMC	FA-03A2 RE	* 5 ⁹ 5 ⁹	57 53
23	Loop Antenna	Schwarzbeck	FMZB 1519B	1519B-224		2025/6/28
24	loop antenna	ZHINAN	ZN30900A	GTS534		67167
25	40G Horn antenna	A/H/System	SAS-574	588		2025/6/28
26	Amplifier	AEROFLEX	Aeroflex	097		2025/6/28
27	Power Metter	KEYSIGHT	N1912AP	N/A	A.05.00	2025/6/28

Continuous disturbance									
No.	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Calibrated until			
1	843 Shield Room	C/ R/ T	843			2027/6/21			
2	AMN	ROHDE&SCHWARZ	ESH3-Z5	831551852	01.0	2025/6/30			
3	Pulse limiter	ROHDE&SCHWARZ	ESH3Z2	357881052		2025/6/28			
4	EMI TEST RECEIVER	ROHDE&SCHWARZ	ESCI	100428	V4.42.SP3	2025/6/30			
5	Coaxial cable	ZDECL	Z302S	18091904	P	2025/6/30			
6	ISN	Schwarzbeck	NTFM8158	183	S 1 S	2025/6/30			
7	Voltage sensor	Schwarzbeck	TK 9420	01189	010	2024/11/16			
8	EZ-EMC	Frad	EMC-con3A1.1			6° 16°			
9	Current Probe	FCC	F-52B	199453	212	2025/5/27			
10	Communication test set	R&S	CMW500	108058	B.19.07 (E1962B)	2025/6/28			
11	Communication test set	Agilent	E5515C	MY50102567	V3.5.80	2025/6/28			

Radiated emission(No.2 Chamber)								
No.	Equipment	Manufacturer	Model No.	Serial No.	Firmware version	Calibrated until		
1	966 Chamber	C/ R/ T	966			2026/11/14		
2	Double Ridged Broadband Horn Antenna	Schwarzbeck	BBHA 9120 D	01911	010	2026/7/07		
3	Broadband Antenna	Schwarzbeck	VULB 9168	1471	P AP AP	2025/7/06		
4	Amplifier	Agilent	8449B	3008A01838		2025/6/30		
5	Preamplifier	Schwarzbeck	BBV 9743 B	00500		2025/5/23		
6	EMI TEST RECEIVER	R&S	ESCI7	100861	\$ <u>4</u> \$	2024/11/27		
7	Spectrum Analyzer	KEYSIGHT	N9020A	MY51289897	A.14.16	2025/6/28		
8	EMI test software	Farad	EZ-EMC		Ver. FARAD-3A1+	212		
9	Coaxial cable	Rosenberg	8m	0,0		2024/11/27		
10	Coaxial cable	Times	2m		SI SY	2024/11/27		



S.P.	C'S'D	or P	C'EB	CT.B	C'S B	c
Shen	zhen C	TB Testi	ng Tech	nology	Co., Ltd	١.

11	Coaxial cable	Times	2m			2024/11/27
12	Coaxial cable	Times	01m 0	616	010	2024/11/27
13	loop antenna	Schwarzbeck	FMZB 1519B	1519B-224		2025/6/29
14	Communication test set	R&S	CMW500	108058	B.19.07 (E1962B)	2025/6/28
15	Communication test set	Agilent	E5515C	MY50102567	V3.5.80	2025/6/28
6	Communication test set	Agilent	E5515C	MY50102567	V3.5.80	2025/6/2

0

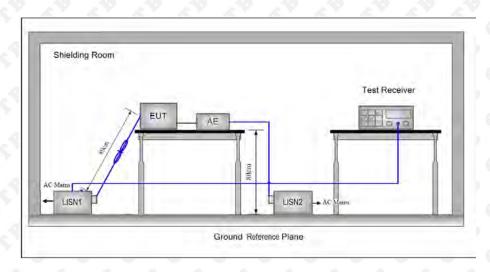
C.S.B

5



6. AC POWER LINE CONDUCTED EMISSION

6.1 Block Diagram Of Test Setup



6.2 Limit

Table 4 – AC power-line conducted emissions limits							
Frequency (MHz)	Conducted limit (dBµV)	1					
	Quasi-peak	Average					
0.15 - 0.5	66 to 56 ^{Note 1}	56 to 46 ^{Note 1}					
0.5 - 5	56	46					
5 - 30	60	50					

Note 1: The level decreases linearly with the logarithm of the frequency.

* Decreasing linearly with the logarithm of the frequency

6.3 Test procedure

- 1) The mains terminal disturbance voltage test was conducted in a shielded room.
- 2) The EUT was connected to AC power source through a LISN 1 (Line Impedance Stabilization Network) which provides a $50\Omega/50\mu$ H + 5Ω linear impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multiple power cables to a single LISN provided the rating of the LISN was not exceeded.
- 3) The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane,
- 4) The test was performed with a vertical ground reference plane. The rear of the EUT shall be 0,4 m from the vertical ground reference plane. The vertical ground reference plane was bonded to the horizontal ground reference plane. The LISN 1 was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane for LISNs mounted on top of the ground reference plane.



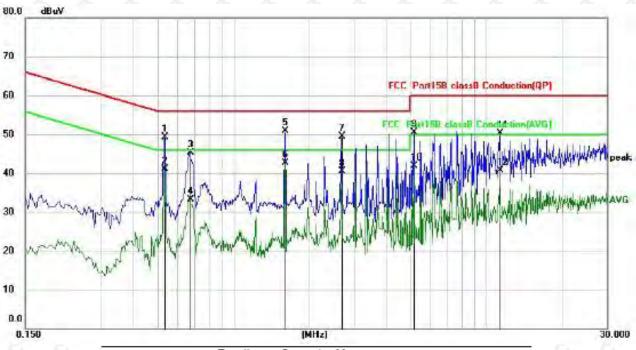
This distance was between the closest points of the LISN 1 and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the LISN 2.

- 5) In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10:2013 on conducted measurement.
- 6) All modes were tested at AC 120V and 240V, only the worst result of AC 120V 60Hz was reported.
- If a EUT received DC power from the USB Port of Notebook PC, the PC's adapter received AC120V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.



6.4 Test Result



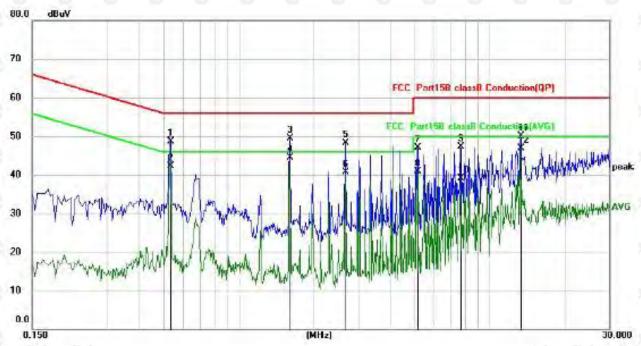


No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector
1		0.5340	38.77	10.54	49.31	56.00	-6.69	QP
2		0.5340	30.63	10.54	41.17	46.00	-4.83	AVG
3		0.6780	34.70	10.70	45.40	56.00	-10.60	QP
4		0.6780	22.59	10.70	33.29	46.00	-12.71	AVG
5		1.6019	39.61	11.33	50.94	56.00	-5.06	QP
6	*	1.6019	31.32	11.33	42.65	46.00	-3.35	AVG
7		2.6659	37.85	11.73	49.58	56.00	-6.42	QP
8		2.6659	28.86	11.73	40.59	46.00	-5.41	AVG
9		5.1779	38.17	12.30	50.47	60.00	-9.53	QP
10		5.1779	29.59	12.30	41.89	50.00	-8.11	AVG
11		11.2577	37.02	13.27	50.29	60.00	-9.71	QP
12		11.2577	27.40	13.27	40.67	50.00	-9.33	AVG

Remark:

Factor = Cable loss + LISN factor, Margin = Measurement – Limit





N: Worst case-GFSK(low channel)

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector
1		0.5340	38.12	10.54	48.66	56.00	-7.34	QP
2		0.5340	31.86	10.54	42.40	46.00	-3.60	AVG
3		1.5980	38.20	11.33	49.53	56.00	-6.47	QP
4	*	1.5980	33.10	11.33	44.43	46.00	-1.57	AVG
5		2.6619	36.58	11.73	48.31	56.00	-7.69	QP
6		2.6619	28.94	11.73	40.67	46.00	-5.33	AVG
7		5.1660	34.77	12.30	47.07	60.00	-12.93	QP
8		5.1660	28.59	12.30	40.89	50.00	-9.11	AVG
9		7.6700	34.34	13.01	47.35	60.00	-12.65	QP
10		7.6700	26.17	13.01	39.18	50.00	-10.82	AVG
11		13.2980	36.75	13.31	50.06	60.00	-9.94	QP
12		13.2980	33.67	13.31	46.98	50.00	-3.02	AVG

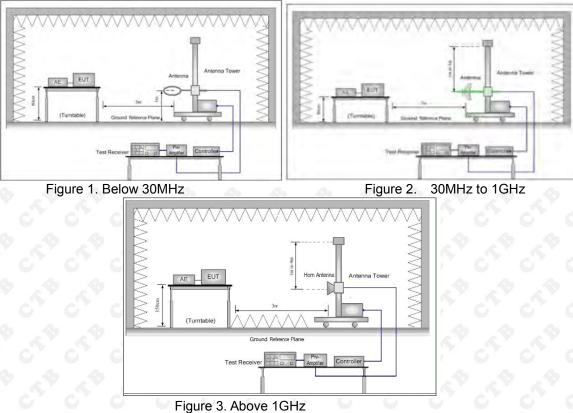
Remark:

Factor = Cable loss + LISN factor, Margin = Measurement – Limit



7. RADIATED SPURIOUS EMISSION

7.1 Block Diagram Of Test Setup



Tigure 5. Above T

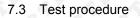
7.2 Limit

Spurious Emissions:

Frequency	Field strength (microvolt/meter)	Limit (dBµV/m)	Remark	Measurement distance (m)
0.009MHz-0.490MHz	2400/F(kHz)	0-0	67 6	300
0.490MHz-1.705MHz	24000/F(kHz)	\$	\$. \$	30
1.705MHz-30MHz	30	0-0	0 0	30
30MHz-88MHz	100	40.0	Quasi-peak	3
88MHz-216MHz	150	43.5	Quasi-peak	3
216MHz-960MHz	200	46.0	Quasi-peak	
960MHz-1GHz	500	54.0	Quasi-peak	3
Above 1GHz	500	54.0	Average	

Note: 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

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Below 1GHz test procedure as below:

a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation.

b.The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.

c.The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

d.For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) and the rota table table was turned from 0 degrees to 360 degrees to find the maximum reading.

e.The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

f.If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

Above 1GHz test procedure as below:

g.Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber and change form table 0.8 meter to 1.5 meter(Above 18GHz the distance is 1 meter and table is 1.5 meter). h.Test the EUT in the lowest channel ,the middle channel ,the Highest channel

i.Repeat above procedures until all frequencies measured was complete.

j. Full battery is usedduring test

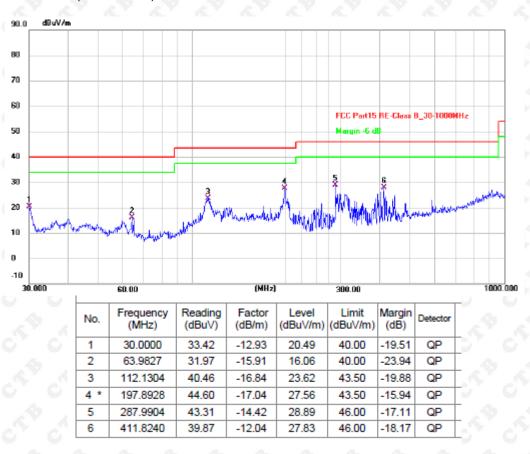
Receiver set:

Frequency	Detector	RBW	VBW	Remark
0.009MHz-0.090MHz	Peak	10kHz	30KHz	Peak
0.009MHz-0.090MHz	Average	10kHz	30KHz	Average
0.090MHz-0.110MHz	Quasi-peak	10kHz	30KHz	Quasi-peak
0.110MHz-0.490MHz	Peak	10kHz	30KHz	Peak
0.110MHz-0.490MHz	Average	10kHz	30KHz	Average
0.490MHz -30MHz	Quasi-peak	10kHz	30kHz	Quasi-peak
30MHz-1GHz	Quasi-peak	120 kHz	300KHz	Quasi-peak
	Peak	1MHz	3MHz	Peak
Above 1GHz	Peak	1MHz	10Hz	Average



7.4 Test Result

Below 1GHz Test Results: Antenna polarity: H Worst case-GFSK(low channel)



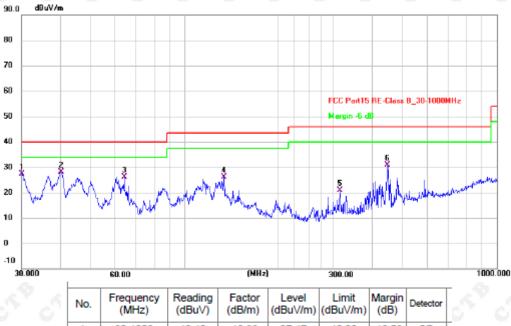
Remark: Factor = Cable lose + Antenna factor - Pre-amplifier; Margin = Measurement- Limit



Shenzhen CTB Testing Technology Co., Ltd.

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Antenna polarity: V Worst case-GFSK(low channel)



	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)		S
1	30.1052	40.40	-12.93	27.47	40.00	-12.53	QP	
2 *	40.1347	40.85	-12.62	28.23	40.00	-11.77	QP	1
3	63.9827	42.02	-15.91	26.11	40.00	-13.89	QP	P
4	133.6187	40.95	-14.83	26.12	43.50	-17.38	QP	Γ.
5	314.3763	34.42	-13.58	20.84	46.00	-25.16	QP	
6	446.4140	41.74	-10.96	30.78	46.00	-15.22	QP	~

Factor = Cable lose + Antenna factor - Pre-amplifier; Margin = Measurement- Limit Remark:



Above 1 GHz Test Results:

CH Low (2402MHz) Horizontal:

Frequency	Reading Result	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector Type
4804	58.24	-3.65	54.59	74.00	-19.41	peak
4804	49.02	-3.65	45.37	54.00	-8.63	AVG
7206	61.10	-0.95	60.15	74.00	-13.85	peak
7206	42.60	-0.95	41.65	54.00	-12.35	AVG

Margin = Emission level - Limits

Vertical:

Frequency	Reading Result	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector Type
4804	58.70	-3.65	55.05	74.00	-18.95	peak
4804	49.87	-3.65	46.22	54.00	-7.78	AVG
7206	59.53	-0.95	58.58	74.00	-15.42	peak
7206	42.00	-0.95	41.05	54.00	-12.95	AVG



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CH Middle (2441MHz) Horizontal:

Frequency	Reading Result	Factor	Emission Level	Limits	Margin	
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector Type
4882.00	59.72	-3.54	56.18	74.00	-17.82	peak
4882.00	46.88	-3.54	43.34	54.00	-10.66	AVG
7323.00	56.50	-0.81	55.69	74.00	-18.31	peak
7323.00	41.82	-0.81	41.01	54.00	-12.99	AVG

Remark: Factor = Antenna Factor + Cable Loss – Pre-amplifier. Emission level = Reading Result + Factor, Margin = Emission level - Limits

Vertical:

Frequency	Reading Result	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector Type
4882.00	59.17	-3.54	55.63	74.00	-18.37	peak
4882.00	48.38	-3.54	44.84	54.00	-9.16	AVG
7323.00	57.78	-0.81	56.97	74.00	-17.03	peak
7323.00	43.35	-0.81	42.54	54.00	-11.46	AVG

Remark: Factor = Antenna Factor + Cable Loss – Pre-amplifier. Emission level = Reading Result + Factor, Margin = Emission level - Limits



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CH High (2480MHz) Horizontal:

requency	Reading Result	Factor	Emission Level	Limits	Margin	Detecto
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detecto Type
4960	57.32	-3.43	53.89	74.00	-20.11	peak
4960	49.24	-3.44	45.80	54.00	-8.20	AVG
7440	58.58	-0.77	57.81	74.00	-16.19	peak
7440	40.90	-0.77	40.13	54.00	-13.87	AVG

Remark: Factor = Antenna Factor + Cable Loss – Pre-amplifier. Emission level = Reading Result + Factor, Margin = Emission level - Limits

Vertical:

Frequency	Reading Result	Factor	Emission Level	Limits	Margin	4
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Detector Type
4960	57.21	-3.43	53.78	74.00	-20.22	peak
4960	47.38	-3.44	43.94	54.00	-10.06	AVG
7440	61.49	-0.77	60.72	74.00	-13.28	peak
7440	40.20	-0.77	39.43	54.00	-14.57	AVG

The test range is 9K \sim 10 times the main wave, and other spurious below the limit of 20dB will not be reflected in the report



Restricted bands around fundamental frequency (Radiated)

hopping

Operation Mode: TX CH Low (2402MHz) Horizontal (Worst case-GFSK)

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2310.00	56.71	-5.81	50.90	74.00	-23.10	peak
2310.00		-5.81		54.00	A 1	AVG
2390.00	56.02	-5.84	50.18	74.00	-23.82	peak
2390.00	616	-5.84	010	54.00	S 10	AVG

Vertical:

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2310.00	55.94	-5.81	50.13	74.00	-23.87	peak
2310.00		-5.81		54.00	ST S	AVG
2390.00	55.11	-5.84	49.27	74.00	-24.73	peak
2390.00	C' C'	-5.84	610	54.00	0' 10'	AVG

Margin = Emission level - Limits



Operation Mode: TX CH High (2480MHz) Horizontal (Worst case-GFSK)

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2483.50	55.93	-5.81	50.12	74.00	-23.88	peak
2483.50	616	-5.81	510	54.00	510	AVG
2500.00	53.67	-6.06	47.61	74.00	-26.39	peak
2500.00		-6.06		54.00		AVG

Vertical:

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2483.50	56.39	-5.81	50.58	74.00	-23.42	peak
2483.50	CÌ CÌ	-5.81	C'I C'	54.00	67 167	AVG
2500.00	53.84	-6.06	47.78	74.00	-26.22	peak
2500.00		-6.06		54.00		AVG



NO hopping

Operation Mode: TX CH Low (2402MHz) Horizontal (Worst case-GFSK)

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2310.00	56.06	-5.81	50.25	74.00	-23.75	peak
2310.00		-5.81		54.00	A 16	AVG
2390.00	55.10	-5.84	49.26	74.00	-24.74	peak
2390.00	616	-5.84	210	54.00	S 10	AVG

Vertical:

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2310.00	56.28	-5.81	50.47	74.00	-23.53	peak
2310.00		-5.81		54.00	ST S	AVG
2390.00	52.87	-5.84	47.03	74.00	-26.97	peak
2390.00	Cí C	-5.84	610	54.00	010	AVG

Margin = Emission level - Limits



Operation Mode: TX CH High (2480MHz) Horizontal (Worst case-GFSK)

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2483.50	55.60	-5.81	49.79	74.00	-24.21	peak
2483.50	616	-5.81	510	54.00	S 105	AVG
2500.00	54.59	-6.06	48.53	74.00	-25.47	peak
2500.00		-6.06		54.00		AVG

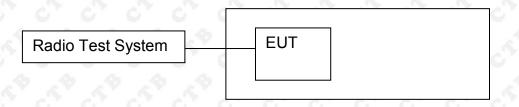
Vertical:

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Туре
2483.50	56.39	-5.81	50.58	74.00	-23.42	peak
2483.50	6 6	-5.81		54.00	0 10	AVG
2500.00	54.96	-6.06	48.90	74.00	-25.10	peak
2500.00	0,0	-6.06		54.00		AVG



8. BAND EDGE AND RF COUNDUCTED SPURIOUS EMISSIONS

8.1 Block Diagram Of Test Setup



8.2 Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

8.3 Test procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum; 2. Set the spectrum analyzer:

Blow 30MHz:

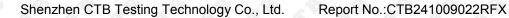
RBW = 100kHz, VBW = 300kHz, Sweep = auto Detector function = peak, Trace = max hold Above 30MHz: RBW = 100KHz, VBW = 300KHz, Sweep = auto Detector function = peak, Trace = max hold



8.4 Test Result

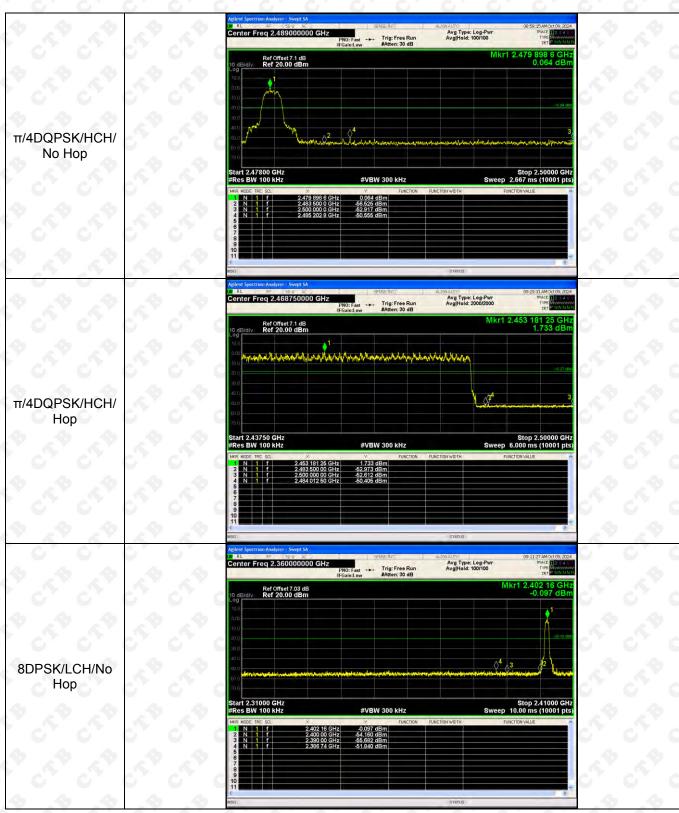




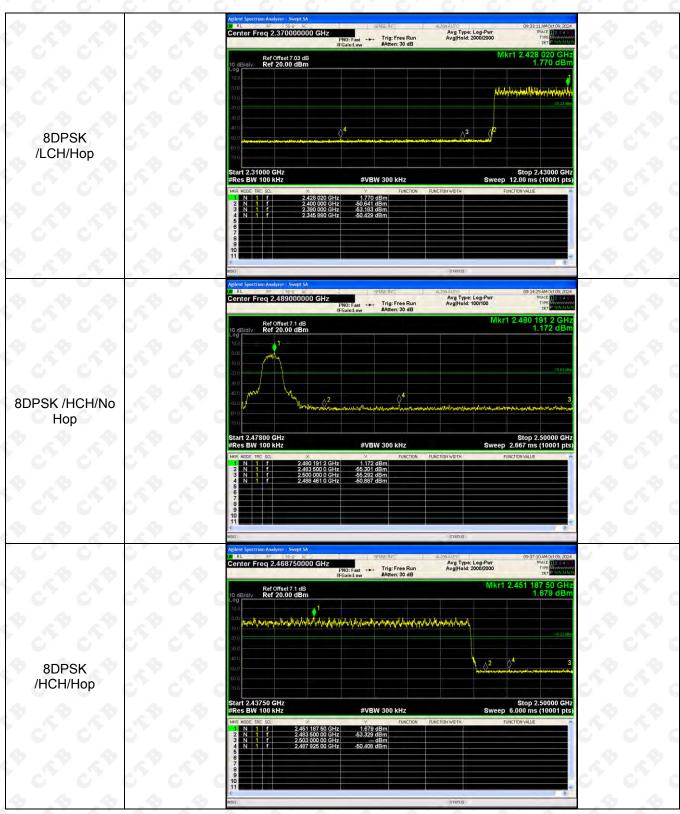








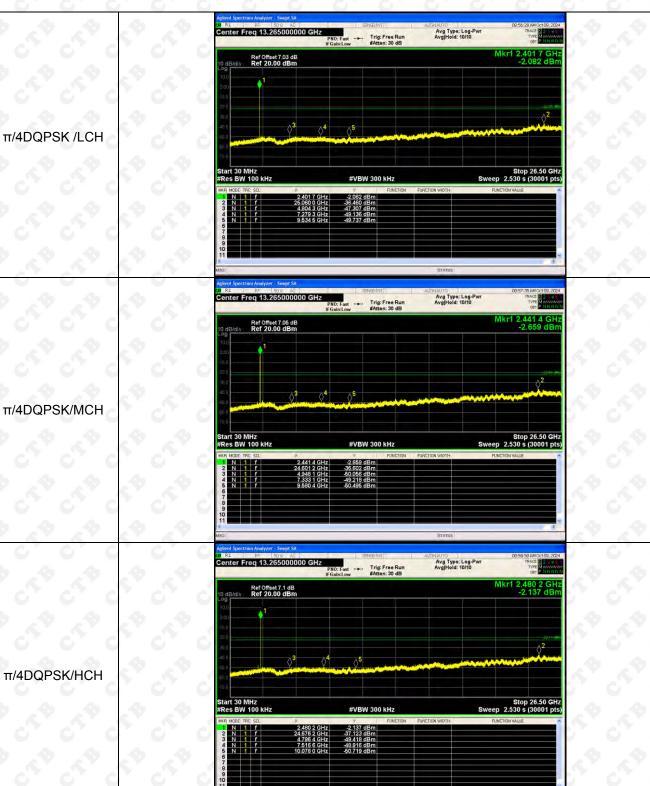






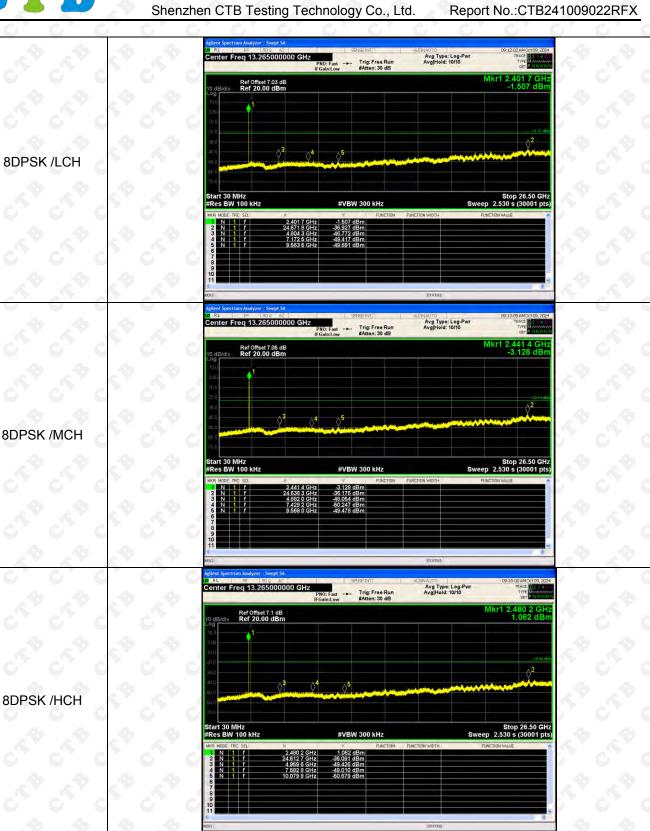






Report

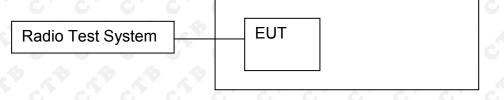






9. COUDUCTED PEAK OUTPUT POWER

9.1 Block Diagram Of Test Setup



9.2 Limit

For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.

9.3 Test procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

2. Set the spectrum analyzer: RBW = 2MHz. VBW = 6MHz. Sweep = auto; Detector Function = Peak.

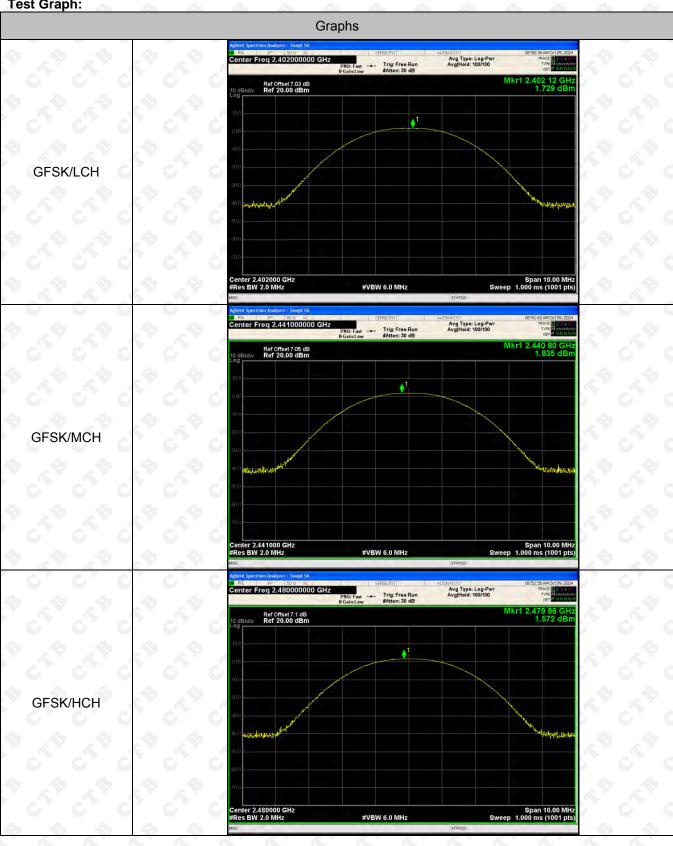
3. Keep the EUT in transmitting at lowest, middle and highest channel individually. Record the max value.

Mode	Channel.	Maximum Peak Output Power [dBm]	Limit [dBm]	Verdict
EDR mode (GFSK)	LCH	1.729	20.97	PASS
	MCH	1.835	20.97	PASS
	НСН	1.572	20.97 🕥	PASS
EDR mode (π/4DQPSK)	LCH	2.415	20.97	PASS
	MCH	2.535	20.97	PASS
	НСН	2.205	20.97	PASS
	LCH	2.675	20.97	PASS
EDR mode (8DPSK)	MCH	2.807	20.97	PASS
	НСН	2.445	20.97	PASS

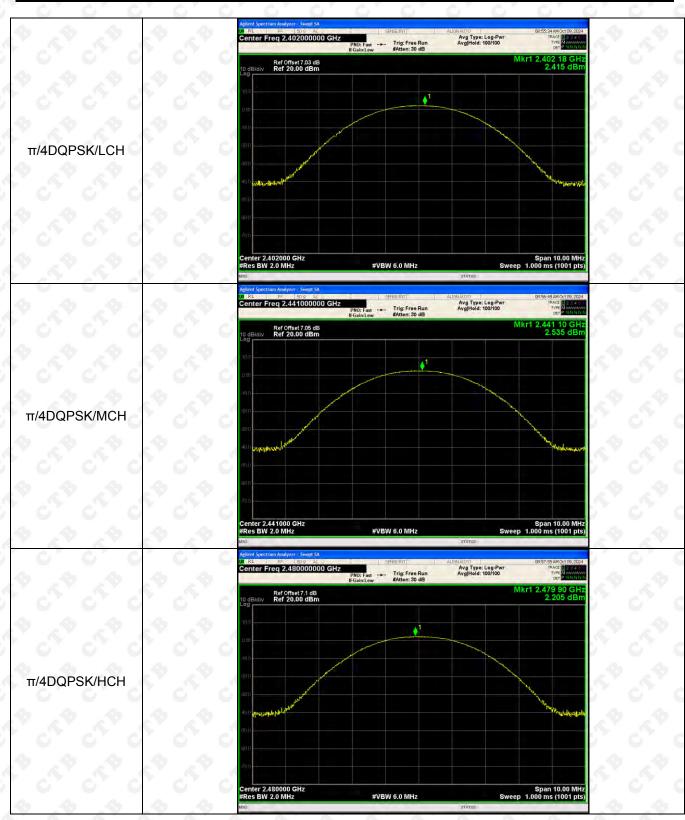
9.4 Test Result



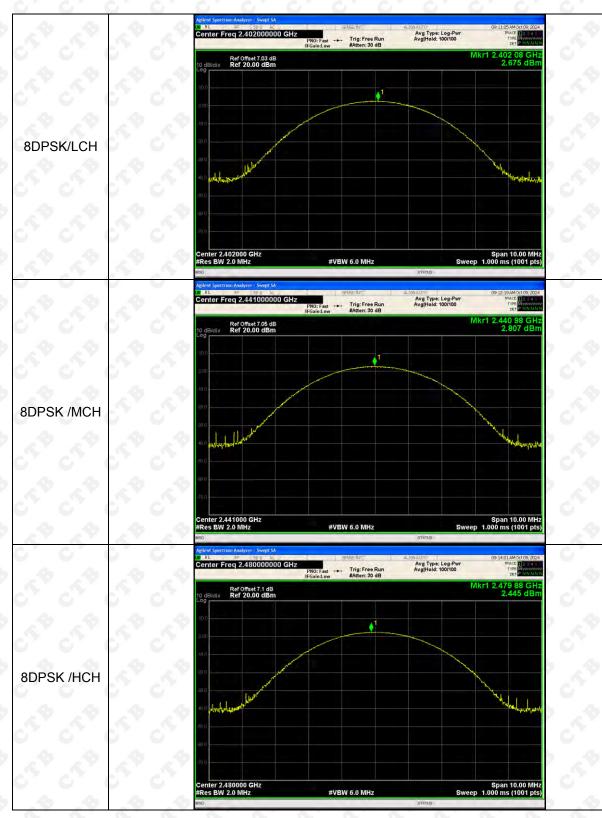




P



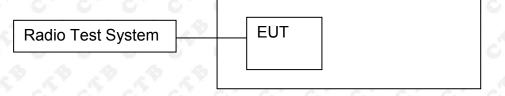






10. 20DB OCCUPIED BANDWIDTH

10.1 Block Diagram Of Test Setup



10.2 Limit

Alternatively, frequency hopping systems operating in the 2400-2483.5MHz band may have hopping channel carrier frequencies that are separated by 25kHz or two-thirds of the 20dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125mw.

10.3 Test procedure

- 1. Rem1. Set RBW = 30 kHz.
- 2. Set the video bandwidth (VBW) \ge 3 x RBW.
- 3. Detector = Peak.
- 4. Trace mode = max hold.
- 5. Sweep = auto couple.
- 6. Allow the trace to stabilize.

7. Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

10.4 Test Result

Test Mode	Frequency	20dB Bandwidth (MHz)	Result
P. P. P.	Low channel	0.856	PASS
GFSK	Mid channel	0.861	PASS
	High channel	0.867	PASS
V V V	Low channel	1.322	PASS
π/4DQPSK	Mid channel	1.276	PASS
	High channel	1.267	PASS
AY AY AY	Low channel	1.276	PASS
8DPSK	Mid channel	1.283	PASS
	High channel	1.321	PASS

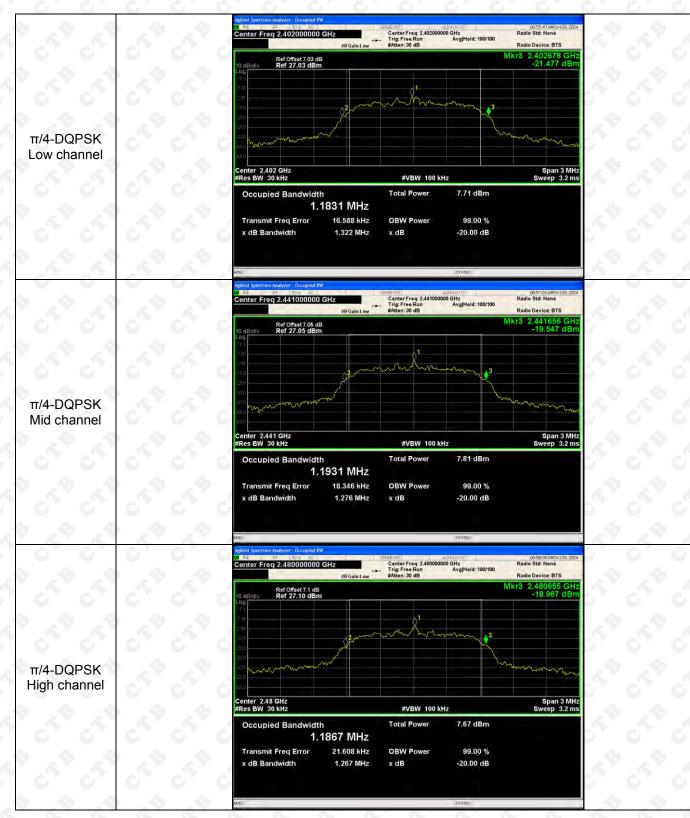
Note: All modes of operation were Pre-scan and the worst-case emissions are reported.



Test Graph:









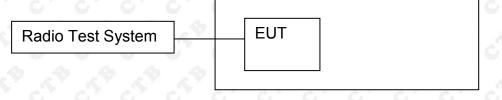


Report



11. CARRIERFREQUENCIES SEPARATION

11.1 Block Diagram Of Test Setup



11.2 Limit

Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 0.125W.

11.3 Test procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port

to the spectrum.

2. Set the spectrum analyzer: RBW = 20kHz. VBW = 60kHz , Span = 2MHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.

3. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section Submit this plot.

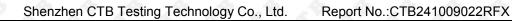
Mode	Channel.	Carrier Frequency Separation [MHz]	Limit(2/3 of the 20dB bandwidth MHz)	Verdict
GFSK	LCH	1.006	0.571	PASS
GFSK	MCH	1.000	0.574	PASS
GFSK	HCH	1.002	0.578	PASS
π/4DQPSK	LCH	1.008	0.881	PASS
π/4DQPSK	MCH	1.002	0.851	PASS
π/4DQPSK	HCH	1.004	0.845	PASS
8DPSK	LCH	1.000	0.851	PASS
8DPSK	MCH	1.004	0.855	PASS
8DPSK	HCH	G G 1.004 G G	0.881	PASS

11.4 Test Result

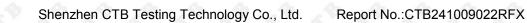


Test Graph









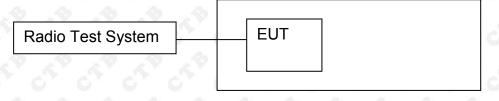
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12. HOPPING CHANNEL NUMBER

12.1 Block Diagram Of Test Setup



12.2 Limit

Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.

12.3 Test procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum. 2. Set the spectrum analyzer: RBW = 100kHz. VBW = 300kHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.

3. Allow the trace to stabilize. It may prove necessary to break the span up to sections. in order to clearly show all of the hopping frequencies. The limit is specified in one of the subparagraphs of this Section.

4. Set the spectrum analyzer: Start Frequency = 2.4GHz, Stop Frequency = 2.4835GHz. Sweep=auto;

12.4 Test Result

Mode	Number of Hopping Channel	Limit	Verdict	
GFSK	Нор	79	≥15	PASS
π/4DQPSK	Нор	79	≥15	PASS
8DPSK	Нор	79	≥15	PASS



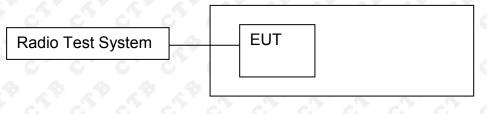


Report



13. DWELL TIME

13.1 Block Diagram Of Test Setup



13.2 Limit

Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

13.3 Test procedure

Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.
 Set spectrum analyzer span = 0. Centred on a hopping channel;

3. Set RBW = 1MHz and VBW = 3MHz.Sweep = as necessary to capture the entire dwell time per hopping channel. Set the EUT for DH5, DH3 and DH1 packet transmitting.

4. Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation. The limit is specified in one of the subparagraphs of this Section. Submit this plot(s).

Mode	Packet	Channel	Pulse Time (ms)	Total Dwell Time (ms)	Limit (ms)	Verdict	
\$ x	DH1	LCH	0.382	122.24	400	PASS	
6	DH1	MCH	0.383	122.56	400	PASS	
4	DH1	HCH	0.383	122.56	400	PASS	
5	DH3	LCH	1.636	261.76	400	PASS	
GFSK	DH3	MCH	1.644	263.04	400	PASS	
8 6	DH3	HCH	1.643	262.88	400	PASS	
C	DH5	LCH	2.894	308.693	400	PASS	
\$ 1	DH5	MCH	2.894	308.693	400	PASS	
ిం	DH5	HCH	2.894	308.693	400	PASS	

13.4 Test Result

Worst case-GFSK:

Remark: DH5 Packet permit maximum 1600 / 79 / 6 hops per second in each channel (5 time slots RX, 1 time slot TX).

DH3 Packet permit maximum 1600 / 79 / 4 hops per second in each channel (3 time slots RX, 1 time slot TX).

DH1 Packet permit maximum 1600 / 79 /2 hops per second in each channel

(1 time slot RX, 1 time slot TX). So, the Dwell Time can be calculated as follows:

DH5:1600/79/6*0.4*79*(MkrDelta)/1000 DH3:1600/79/4*0.4*79*(MkrDelta)/1000 DH1:1600/79/2*0.4*79*(MkrDelta)/1000 Remark: Mkr Delta is once pulse time.



Test Graph

	Graphs
GFSK_DH1/LCH	Addres Spectrum Analyzer, Sweet SA. SPIES INT ALOPATION OP 3721AMOORD Center Fireg 2.402000000 GHz IFGalantew Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ Center Fireg 2.402000000 GHz IFGalantew Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ 10 Ref Offset 7.03 dB Attents 0 dB Attents 0 dB -11.03 dB 10 Trig Dalap 500.0 µ Y Y Trig Dalap 500.0 µ 10 Genter Fireg 2.402000000 GHz Y Y Trig Dalap 500.0 µ 10 Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ 10 Y Y Trig Dalap 500.0 µ Trig Dalap 500.0 µ Trig Dalap 500.0 µ 10 Trig Dalap 500.0 µ Y Y Trig Dalap 500.0 µ Trig Dalap 500.0 µ 10 Trig Dalap 500.0 µ Y Y Trig Dalap 500.0 µ Trig Dalap 500.0 µ 10 Trig Dalap 500.0 µ Y Y Trig Dalap 500.0 µ Trig Dalap 500.0 µ 10 Trig Dalap 50
GFSK_DH1/MCH	All of the second secon
GFSK_DH1/HCH	Addred Spectrum Analyzer, Sweet 54 Center Freq 2.480000000 GHz Frain Low Frain Low F



Trig Delay-500.0 µs Trig: Video #Atten: 30 dB Ref Offset 7.03 dB Ref 20.00 dBm um an and a break the protocol and a second second Span 0 Hz p 3.000 ms (10001 pts r 2.4020 W 1.0 M #VBW 3.0 MHz 1.636 ms (Δ) 2.13 dB 38.10 μs -12.35 dBm NSE:INT Trig Delay-500.0 µs Trig: Video #Atten: 30 dB Avg Type: Log-Pwr nter Freg 2.4410 ----PNO: Fast IFGain:Lew Ref Offset 7.05 dB Ref 20.00 dBm Δ. X₂ GFSK_DH3/MCH 0 GHz Span 0 H Sweep 3.000 ms (10001 pt #VBW 3.0 MHz 1.644 ms (∆ 499.8 µs -3.50 d

Shenzhen CTB Testing Technology Co., Ltd.

enter Freg 2.402000000 GHz

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a da barren en e	
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F 1 t 500.1 us -12.55 dBm	

GFSK_DH3/LCH

GFSK_DH3/HCH

Report No.:CTB241009022RFX

Avg Type: Log-Pw







14. PSEUDORANDOM FREQUENCY

14.1 Limit

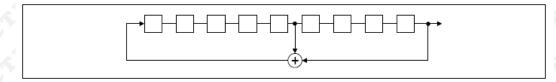
Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

Alternatively. Frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW. The system shall hop to channel frequencies that are selected at the system hopping rate from a Pseudorandom ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

14.2 Test procedure

The pseudorandom sequence may be generated in a nine-stage shift register whose 5th and 9th stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first ONE of 9 consecutive ONEs; i.e. the shift register is initialized with nine ones.

- Number of shift register stages: 9
- Length of pseudo-random sequence: 29 -1 = 511 bits
- Longest sequence of zeros: 8 (non-inverted signal)



An example of Pseudorandom Frequency Hopping Sequence as follow:

20 62 46 77	7	64	8	73	16	75	1	
	_						<u> </u>	

Each frequency used equally on the average by each transmitter. The system receivers have input bandwidths that match the hopping channel bandwidths of their Corresponding transmitters and shift frequencies in synchronization with the transmitted signals.

14.3 Test Result

The device does not have the ability to be coordinated with other FHSS systems in an effort to avoid the simultaneous occupancy of individual hopping frequencies by multiple transmitters.



15. ANTENNA REQUIREMENT

15.203 requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 15.247(b) (4) requirement:

The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

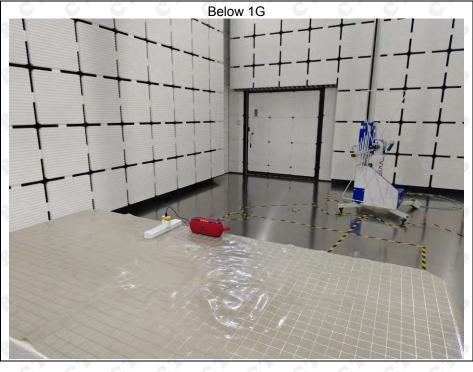
EUT Antenna:

The antenna PCB antenna. The best case gain of the antenna is -0.76dBi.



16. EUT TEST SETUP PHOTOGRAPHS

Radiated Emission







Conducted emissions



***** END OF REPORT *****